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Details

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Product Status	Active
Core Processor	S08
Core Size	8-Bit
Speed	40MHz
Connectivity	I ² C, SCI, SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	54
Program Memory Size	48KB (48K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 16x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mc9s08aw48cpue

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Chapter 2 Pins and Connections

2.3.1 Power (V_{DD} , 2 x V_{SS} , V_{DDAD} , V_{SSAD})

 V_{DD} and V_{SS} are the primary power supply pins for the MCU. This voltage source supplies power to all I/O buffer circuitry and to an internal voltage regulator. The internal voltage regulator provides regulated lower-voltage source to the CPU and other internal circuitry of the MCU.

Typically, application systems have two separate capacitors across the power pins. In this case, there should be a bulk electrolytic capacitor, such as a 10- μ F tantalum capacitor, to provide bulk charge storage for the overall system and a 0.1- μ F ceramic bypass capacitor located as near to the paired V_{DD} and V_{SS} power pins as practical to suppress high-frequency noise. The MC9S08AW60 has a second V_{SS} pin. This pin should be connected to the system ground plane or to the primary V_{SS} pin through a low-impedance connection.

 V_{DDAD} and V_{SSAD} are the analog power supply pins for the MCU. This voltage source supplies power to the ADC module. A 0.1- μ F ceramic bypass capacitor should be located as near to the analog power pins as practical to suppress high-frequency noise.

2.3.2 Oscillator (XTAL, EXTAL)

Out of reset, the MCU uses an internally generated clock (self-clocked mode — f_{Self_reset}) equivalent to about 8-MHz crystal rate. This frequency source is used during reset startup and can be enabled as the clock source for stop recovery to avoid the need for a long crystal startup delay. This MCU also contains a trimmable internal clock generator (ICG) module that can be used to run the MCU. For more information on the ICG, see the Chapter 8, "Internal Clock Generator (S08ICGV4)."

The oscillator amplitude on XTAL and EXTAL is gain limited for low-power oscillation. Typically, these pins have a 1-V peak-to-peak signal. For noisy environments, the high gain output (HGO) bit can be set to enable rail-to-rail oscillation.

The oscillator in this MCU is a Pierce oscillator that can accommodate a crystal or ceramic resonator in either of two frequency ranges selected by the RANGE bit in the ICGC1 register. Rather than a crystal or ceramic resonator, an external oscillator can be connected to the EXTAL input pin.

Refer to Figure 2-4 for the following discussion. R_S (when used) and R_F should be low-inductance resistors such as carbon composition resistors. Wire-wound resistors, and some metal film resistors, have too much inductance. C1 and C2 normally should be high-quality ceramic capacitors that are specifically designed for high-frequency applications.

 R_F is used to provide a bias path to keep the EXTAL input in its linear range during crystal startup and its value is not generally critical. Typical systems use 1 M Ω to 10 M Ω . Higher values are sensitive to humidity and lower values reduce gain and (in extreme cases) could prevent startup.

C1 and C2 are typically in the 5-pF to 25-pF range and are chosen to match the requirements of a specific crystal or resonator. Be sure to take into account printed circuit board (PCB) capacitance and MCU pin capacitance when sizing C1 and C2. The crystal manufacturer typically specifies a load capacitance which is the series combination of C1 and C2 which are usually the same size. As a first-order approximation, use 10 pF as an estimate of combined pin and PCB capacitance for each oscillator pin (EXTAL and XTAL).



Lowe	st <- Pin Function Priori	ty -> Highest	Beference ¹				
Port Pins	Alternate Function	Alternate Function	neierence				
PTF3–PTF0	TPM1CH5– TPM1CH2		Chapter 10, "Timer/PWM (S08TPMV2)"				
PTG4–PTG0	KBI1P4–KBI1P0		Chapter 9, "Keyboard Interrupt (S08KBIV1)"				
PTG6–PTG5	EXTAL-XTAL		Chapter 8, "Internal Clock Generator (S08ICGV4)"				

Table 2-1. Pin Sharing Priority

See the listed chapter for information about modules that share these pins.

When an on-chip peripheral system is controlling a pin, data direction control bits still determine what is read from port data registers even though the peripheral module controls the pin direction by controlling the enable for the pin's output buffer. See the Chapter 6, "Parallel Input/Output" chapter for more details.

Pullup enable bits for each input pin control whether on-chip pullup devices are enabled whenever the pin is acting as an input even if it is being controlled by an on-chip peripheral module. When the PTD7, PTD3, PTD2, and PTG4 pins are controlled by the KBI module and are configured for rising-edge/high-level sensitivity, the pullup enable control bits enable pulldown devices rather than pullup devices.

NOTE

When an alternative function is first enabled it is possible to get a spurious edge to the module, user software should clear out any associated flags before interrupts are enabled. Table 2-1 illustrates the priority if multiple modules are enabled. The highest priority module will have control over the pin. Selecting a higher priority pin function with a lower priority function already enabled can cause spurious edges to the lower priority module. It is recommended that all modules that share a pin be disabled before enabling another module.



Chapter 4 Memory

4.4.3 **Program and Erase Command Execution**

The steps for executing any of the commands are listed below. The FCDIV register must be initialized and any error flags cleared before beginning command execution. The command execution steps are:

Write a data value to an address in the FLASH array. The address and data information from this write is latched into the FLASH interface. This write is a required first step in any command sequence. For erase and blank check commands, the value of the data is not important. For page erase commands, the address may be any address in the 512-byte page of FLASH to be erased. For mass erase and blank check commands, the address can be any address in the FLASH memory. Whole pages of 512 bytes are the smallest block of FLASH that may be erased. In the 60K version, there are two instances where the size of a block that is accessible to the user is less than 512 bytes: the first page following RAM, and the first page following the high page registers. These pages are overlapped by the RAM and high page registers respectively.

NOTE

Do not program any byte in the FLASH more than once after a successful erase operation. Reprogramming bits to a byte which is already programmed is not allowed without first erasing the page in which the byte resides or mass erasing the entire FLASH memory. Programming without first erasing may disturb data stored in the FLASH.

- 2. Write the command code for the desired command to FCMD. The five valid commands are blank check (\$05), byte program (\$20), burst program (\$25), page erase (\$40), and mass erase (\$41). The command code is latched into the command buffer.
- 3. Write a 1 to the FCBEF bit in FSTAT to clear FCBEF and launch the command (including its address and data information).

A partial command sequence can be aborted manually by writing a 0 to FCBEF any time after the write to the memory array and before writing the 1 that clears FCBEF and launches the complete command. Aborting a command in this way sets the FACCERR access error flag which must be cleared before starting a new command.

A strictly monitored procedure must be obeyed or the command will not be accepted. This minimizes the possibility of any unintended changes to the FLASH memory contents. The command complete flag (FCCF) indicates when a command is complete. The command sequence must be completed by clearing FCBEF to launch the command. Figure 4-3 is a flowchart for executing all of the commands except for burst programming. The FCDIV register must be initialized before using any FLASH commands. This only must be done once following a reset.



Chapter 5 Resets, Interrupts, and System Configuration

- Illegal opcode detect
- Background debug forced reset
- The reset pin ($\overline{\text{RESET}}$)
- Clock generator loss of lock and loss of clock reset

Each of these sources, with the exception of the background debug forced reset, has an associated bit in the system reset status register. Whenever the MCU enters reset, the internal clock generator (ICG) module switches to self-clocked mode with the frequency of f_{Self_reset} selected. The reset pin is driven low for 34 bus cycles where the internal bus frequency is half the ICG frequency. After the 34 bus cycles are completed, the pin is released and will be pulled up by the internal pullup resistor, unless it is held low externally. After the pin is released, it is sampled after another 38 bus cycles to determine whether the reset pin is the cause of the MCU reset.

5.4 Computer Operating Properly (COP) Watchdog

The COP watchdog is intended to force a system reset when the application software fails to execute as expected. To prevent a system reset from the COP timer (when it is enabled), application software must reset the COP timer periodically. If the application program gets lost and fails to reset the COP before it times out, a system reset is generated to force the system back to a known starting point. The COP watchdog is enabled by the COPE bit in SOPT (see Section 5.9.4, "System Options Register (SOPT)" for additional information). The COP timer is reset by writing any value to the address of SRS. This write does not affect the data in the read-only SRS. Instead, the act of writing to this address is decoded and sends a reset signal to the COP timer.

After any reset, the COP timer is enabled. This provides a reliable way to detect code that is not executing as intended. If the COP watchdog is not used in an application, it can be disabled by clearing the COPE bit in the write-once SOPT register. Also, the COPT bit can be used to choose one of two timeout periods (2¹⁸ or 2¹³ cycles of the bus rate clock). Even if the application will use the reset default settings in COPE and COPT, the user should write to write-once SOPT during reset initialization to lock in the settings. That way, they cannot be changed accidentally if the application program gets lost.

The write to SRS that services (clears) the COP timer should not be placed in an interrupt service routine (ISR) because the ISR could continue to be executed periodically even if the main application program fails.

When the MCU is in active background mode, the COP timer is temporarily disabled.

5.5 Interrupts

Interrupts provide a way to save the current CPU status and registers, execute an interrupt service routine (ISR), and then restore the CPU status so processing resumes where it left off before the interrupt. Other than the software interrupt (SWI), which is a program instruction, interrupts are caused by hardware events such as an edge on the IRQ pin or a timer-overflow event. The debug module can also generate an SWI under certain circumstances.

If an event occurs in an enabled interrupt source, an associated read-only status flag will become set. The CPU will not respond until and unless the local interrupt enable is a logic 1 to enable the interrupt. The



Chapter 6 Parallel Input/Output

	7	6	5	4	3	2	1	0
R W	PTASE7	PTASE6	PTASE5	PTASE4	PTASE3	PTASE2	PTASE1	PTASE0
Reset	0	0	0	0	0	0	0	0

Figure 6-12. Output Slew Rate Control Enable for Port A (PTASE)

Table 6-5. PTASE Register Field Descriptions

Field	Description
7:0 PTASE[7:0]	 Output Slew Rate Control Enable for Port A Bits — Each of these control bits determine whether output slew rate control is enabled for the associated PTA pin. For port A pins that are configured as inputs, these bits have no effect. Output slew rate control disabled for port A bit n. Output slew rate control enabled for port A bit n.

_	7	6	5	4	3	2	1	0
R	PTADS7	PTADS6	PTADS5	PTADS4	PTADS3	PTADS2	PTADS1	PTADS0
W								
Reset	0	0	0	0	0	0	0	0

Figure 6-13. Output Drive Strength Selection for Port A (PTASE)

Table 6-6. PTASE Register Field Descriptions

Field	Description
7:0 PTADS[7:0]	 Output Drive Strength Selection for Port A Bits — Each of these control bits selects between low and high output drive for the associated PTA pin. 0 Low output drive enabled for port A bit n. 1 High output drive enabled for port A bit n.



Chapter 6 Parallel Input/Output

6.7.5 Port C I/O Registers (PTCD and PTCDD)

Port C parallel I/O function is controlled by the registers listed below.



Figure 6-19. Port C Data Register (PTCD)

Table 6-12	PTCD	Register	Field	Descriptions
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Field	Description
6:0 PTCD[6:0]	Port C Data Register Bits — For port C pins that are inputs, reads return the logic level on the pin. For port C pins that are configured as outputs, reads return the last value written to this register. Writes are latched into all bits of this register. For port C pins that are configured as outputs, the logic level is driven out the corresponding MCU pin. Reset forces PTCD to all 0s, but these 0s are not driven out the corresponding pins because reset also configures all port pins as high-impedance inputs with pullups disabled.

_	7	6	5	4	3	2	1	0
R W		PTCDD6	PTCDD5	PTCDD4	PTCDD3	PTCDD2	PTCDD1	PTCDD0
Reset	0	0	0	0	0	0	0	0

Figure 6-20. Data Direction for Port C (PTCDD)

Table 6-13. PTCDD Register Field Descriptions

Field	Description
6:0 PTCDD[6:0]	Data Direction for Port C Bits — These read/write bits control the direction of port C pins and what is read for PTCD reads.
	 Input (output driver disabled) and reads return the pin value. Output driver enabled for port C bit n and PTCD reads return the contents of PTCDn.



Source	Orientiar	Description		Effect on CCR				Effect on CCR				Effect on CCR			ess de	ode	and	/cles ¹
Form	Form Operation Description		v	н	I	N	z	с	Addr Moe	Opce	Oper	Bus C)						
ROR opr8a RORA RORX ROR oprx8,X ROR ,X ROR oprx8,SP	Rotate Right through Carry	b7 b0	\$	_	_	\$	\$	\$	DIR INH INH IX1 IX SP1	36 46 56 66 76 9E66	dd ff ff	5 1 5 4 6						
RSP	Reset Stack Pointer	SP ← 0xFF (High Byte Not Affected)	_	-	_	-	-	-	INH	9C		1						
RTI	Return from Interrupt	$\begin{array}{l} SP \leftarrow (SP) + 0x0001; \ Pull \ (CCR) \\ SP \leftarrow (SP) + 0x0001; \ Pull \ (A) \\ SP \leftarrow (SP) + 0x0001; \ Pull \ (X) \\ SP \leftarrow (SP) + 0x0001; \ Pull \ (PCH) \\ SP \leftarrow (SP) + 0x0001; \ Pull \ (PCL) \end{array}$	\$	\$	\$	\$	\$	\$	INH	80		9						
RTS	Return from Subroutine	$SP \leftarrow SP + 0x0001; Pull (PCH)$ $SP \leftarrow SP + 0x0001; Pull (PCL)$	-	-	-	-	-	-	INH	81		6						
SBC #opr8i SBC opr8a SBC opr16a SBC oprx16,X SBC oprx8,X SBC ,X SBC oprx16,SP SBC oprx8,SP	Subtract with Carry	$A \leftarrow (A) - (M) - (C)$	\$	_	_	\$	\$	\$	IMM DIR EXT IX2 IX1 IX SP2 SP1	A2 B2 C2 D2 E2 F2 9ED2 9EE2	ii dd hh II ee ff ff ee ff	2 3 4 3 3 5 4						
SEC	Set Carry Bit	C ← 1	-	-	—	-	-	1	INH	99		1						
SEI	Set Interrupt Mask Bit	l ← 1	-	-	1	-	-	-	INH	9B		1						
STA opr8a STA opr16a STA oprx16,X STA oprx8,X STA ,X STA oprx16,SP STA oprx8,SP	Store Accumulator in Memory	M ← (A)	0	_	_	\$	\$	_	DIR EXT IX2 IX1 IX SP2 SP1	87 C7 D7 E7 F7 9ED7 9EE7	dd hh ll ee ff ff ee ff ff	3 4 4 3 2 5 4						
STHX opr8a STHX opr16a STHX oprx8,SP	Store H:X (Index Reg.)	(M:M + 0x0001) ← (H:X)	0	-	_	\$	\$	-	DIR EXT SP1	35 96 9EFF	dd hh ll ff	4 5 5						
STOP	Enable Interrupts: Stop Processing Refer to MCU Documentation	I bit \leftarrow 0; Stop Processing	_	_	0	_	_	_	INH	8E		2+						
STX opr8a STX opr16a STX oprx16,X STX oprx8,X STX ,X STX oprx16,SP STX oprx8,SP	Store X (Low 8 Bits of Index Register) in Memory	M ← (X)	0	_	_	\$	\$	_	DIR EXT IX2 IX1 IX SP2 SP1	BF CF DF EF 9EDF 9EEF	dd hh II ee ff ff ee ff ff	3443254						
SUB #opr8i SUB opr8a SUB opr16a SUB oprx16,X SUB oprx8,X SUB ,X SUB oprx16,SP SUB oprx8,SP	Subtract	A ← (A) – (M)	\$	_	_	\$	\$	\$	IMM DIR EXT IX2 IX1 IX SP2 SP1	A0 B0 C0 D0 E0 F0 9ED0 9EE0	ii dd hh II ee ff ff ee ff ff	2 3 4 3 3 5 4						
SWI	Software Interrupt	$\begin{array}{c} PC \leftarrow (PC) + 0x0001 \\ Push \ (PCL); \ SP \leftarrow (SP) - 0x0001 \\ Push \ (PCH); \ SP \leftarrow (SP) - 0x0001 \\ Push \ (A); \ SP \leftarrow (SP) - 0x0001 \\ Push \ (A); \ SP \leftarrow (SP) - 0x0001 \\ Push \ (CCR); \ SP \leftarrow (SP) - 0x0001 \\ I \leftarrow I; \\ PCH \leftarrow Interrupt \ Vector \ High \ Byte \\ PCL \leftarrow Interrupt \ Vector \ Low \ Byte \end{array}$	_	_	1	_	_	_	INH	83		11						

Table 7-2. HC	S08 Instruction	Set Summary	(Sheet 6 of 7)	

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Chapter 8 Internal Clock Generator (S08ICGV4)

- Digitally-controlled oscillator (DCO) preserves previous frequency settings, allowing fast frequency lock when recovering from stop3 mode
- DCO will maintain operating frequency during a loss or removal of reference clock
- Post-FLL divider selects 1 of 8 bus rate divisors (/1 through /128)
- Separate self-clocked source for real-time interrupt
- Trimmable internal clock source supports SCI communications without additional external components
- Automatic FLL engagement after lock is acquired
- External oscillator selectable for low power or high gain

8.1.2 Modes of Operation

This is a high-level description only. Detailed descriptions of operating modes are contained in Section 8.4, "Functional Description."

• Mode 1 - Off

The output clock, ICGOUT, is static. This mode may be entered when the STOP instruction is executed.

• Mode 2 — Self-clocked (SCM)

Default mode of operation that is entered immediately after reset. The ICG's FLL is open loop and the digitally controlled oscillator (DCO) is free running at a frequency set by the filter bits.

• Mode 3 — FLL engaged internal (FEI)

In this mode, the ICG's FLL is used to create frequencies that are programmable multiples of the internal reference clock.

- FLL engaged internal unlocked is a transition state that occurs while the FLL is attempting to lock. The FLL DCO frequency is off target and the FLL is adjusting the DCO to match the target frequency.
- FLL engaged internal locked is a state that occurs when the FLL detects that the DCO is locked to a multiple of the internal reference.
- Mode 4 FLL bypassed external (FBE)

In this mode, the ICG is configured to bypass the FLL and use an external clock as the clock source.

• Mode 5 — FLL engaged external (FEE)

The ICG's FLL is used to generate frequencies that are programmable multiples of the external clock reference.

- FLL engaged external unlocked is a transition state that occurs while the FLL is attempting to lock. The FLL DCO frequency is off target and the FLL is adjusting the DCO to match the target frequency.
- FLL engaged external locked is a state which occurs when the FLL detects that the DCO is locked to a multiple of the internal reference.



Chapter 9 Keyboard Interrupt (S08KBIV1)

9.1 Introduction

The MC9S08AW60 Series has one KBI module with eight keyboard interrupt inputs that are shared with port D and port G pins. See Chapter 2, "Pins and Connections," for more information about the logic and hardware aspects of these pins.

9.2 Keyboard Pin Sharing

The KBI input KBIP7 shares a common pin with PTD7 and AD15. When KBIP7 is enabled the pin is forced to its input state regardless of the value of the associated port D data direction bit. The port D pullup enable is still used to control the pullup resistor and the pin state can be sensed through a read of the port D data register (this requires that bit 7 of the port D DDR is 0). In the case that the pin is enabled as an ADC input, both the PTD7 and KBIP7 functions are disabled, including the pullup resistor.

The KBI input KBIP6 shares a common pin with PTD3 and AD11, and KBI input KBIP5 shares a common pin with PTD2 and AD10. The sharing of each of these inputs with port and ADC functions operates in the same way as described above for KBIP7.

The KBI inputs KBIP4 – KBIP0 are shared on common pins with PTG4 – PTG0. These pins all operate in the same way as described above for KBIP7 except that none are shared with an ADC input.

KBIP3 – KBIP0 are always falling-edge/low-level sensitive. KBIP7 – KBIP4 can be configured for rising-edge/high-level or for falling-edge/low-level sensitivity. When any of the inputs KBIP7 – KBIP0 are enabled and configured to detect rising edges/high levels, and the pin pullup is enabled through the corresponding port pullup enable bit for that pin, a pulldown resistor rather than a pullup resistor is enabled on the pin.

PTxPEn (Pull Enable)	PTxDDn (Data Direction)	KBIPEn (KBI Pin Enable)	KBEDGn (KBI Edge Select)	Pullup	Pulldown
0	0	0	x ¹	disabled	disabled
1	0	0	х	enabled	disabled
х	1	0	х	disabled	disabled
1	x	1	0	enabled	disabled
1	x	1	1	disabled	enabled
0	х	1	х	disabled	disabled

¹ x = Don't care



10.4.4 Timer x Channel n Status and Control Register (TPMxCnSC)

TPMxCnSC contains the channel interrupt status flag and control bits that are used to configure the interrupt enable, channel configuration, and pin function.



Figure 10-8. Timer x Channel n Status and Control Register (TPMxCnSC)

Field	Description
7 CHnF	Channel n Flag — When channel n is configured for input capture, this flag bit is set when an active edge occurs on the channel n pin. When channel n is an output compare or edge-aligned PWM channel, CHnF is set when the value in the TPM counter registers matches the value in the TPM channel n value registers. This flag is seldom used with center-aligned PWMs because it is set every time the counter matches the channel value register, which correspond to both edges of the active duty cycle period. A corresponding interrupt is requested when CHnF is set and interrupts are enabled (CHnIE = 1). Clear CHnF by reading TPMxCnSC while CHnF is set and then writing a 0 to CHnF. If another interrupt request occurs before the clearing sequence is complete, the sequence is reset so CHnF would remain set after the clear sequence was completed for the earlier CHnF. This is done so a CHnF interrupt request cannot be lost by clearing a previous CHnF. Reset clears CHnF. Writing a 1 to CHnF has no effect. 0 No input capture or output compare event occurred on channel n 1 Input capture or output compare event occurred on channel n
6 CHnIE	 Channel n Interrupt Enable — This read/write bit enables interrupts from channel n. Reset clears CHnIE. 0 Channel n interrupt requests disabled (use software polling) 1 Channel n interrupt requests enabled
5 MSnB	Mode Select B for TPM Channel n — When CPWMS = 0, $MSnB = 1$ configures TPM channel n for edge-aligned PWM mode. For a summary of channel mode and setup controls, refer to Table 10-5.
4 MSnA	Mode Select A for TPM Channel n — When CPWMS = 0 and MSnB = 0, MSnA configures TPM channel n for input capture mode or output compare mode. Refer to Table 10-5 for a summary of channel mode and setup controls.
3:2 ELSn[B:A]	Edge/Level Select Bits — Depending on the operating mode for the timer channel as set by CPWMS:MSnB:MSnA and shown in Table 10-5, these bits select the polarity of the input edge that triggers an input capture event, select the level that will be driven in response to an output compare match, or select the polarity of the PWM output. Setting ELSnB:ELSnA to 0:0 configures the related timer pin as a general-purpose I/O pin unrelated to any timer channel functions. This function is typically used to temporarily disable an input capture channel or to make the timer pin available as a general-purpose I/O pin when the associated timer channel is set up as a software timer that does not require the use of a pin.

Table 10-4. TPMxCnSC Register Field Descriptions



Chapter 12 Serial Peripheral Interface (S08SPIV3)

The most common uses of the SPI system include connecting simple shift registers for adding input or output ports or connecting small peripheral devices such as serial A/D or D/A converters. Although Figure 12-2 shows a system where data is exchanged between two MCUs, many practical systems involve simpler connections where data is unidirectionally transferred from the master MCU to a slave or from a slave to the master MCU.

12.0.2.2 SPI Module Block Diagram

Figure 12-3 is a block diagram of the SPI module. The central element of the SPI is the SPI shift register. Data is written to the double-buffered transmitter (write to SPI1D) and gets transferred to the SPI shift register at the start of a data transfer. After shifting in a byte of data, the data is transferred into the double-buffered receiver where it can be read (read from SPI1D). Pin multiplexing logic controls connections between MCU pins and the SPI module.

When the SPI is configured as a master, the clock output is routed to the SPSCK pin, the shifter output is routed to MOSI, and the shifter input is routed from the MISO pin.

When the SPI is configured as a slave, the SPSCK pin is routed to the clock input of the SPI, the shifter output is routed to MISO, and the shifter input is routed from the MOSI pin.

In the external SPI system, simply connect all SPSCK pins to each other, all MISO pins together, and all MOSI pins together. Peripheral devices often use slightly different names for these pins.

ICR (hex)	SCL Divider	SDA Hold Value
00	20	7
01	22	7
02	24	8
03	26	8
04	28	9
05	30	9
06	34	10
07	40	10
08	28	7
09	32	7
0A	36	9
0B	40	9
0C	44	11
0D	48	11
0E	56	13
0F	68	13
10	48	9
11	56	9
12	64	13
13	72	13
14	80	17
15	88	17
16	104	21
17	128	21
18	80	9
19	96	9
1A	112	17
1B	128	17
1C	144	25
1D	160	25
1E	192	33
1F	240	33

Table 13-3	IIC	Divider	and	Hold	Values
------------	-----	---------	-----	------	--------

ICR (hex)	SCL Divider	SDA Hold Value
20	160	17
21	192	17
22	224	33
23	256	33
24	288	49
25	320	49
26	384	65
27	480	65
28	320	33
29	384	33
2A	448	65
2B	512	65
2C	576	97
2D	640	97
2E	768	129
2F	960	129
30	640	65
31	768	65
32	896	129
33	1024	129
34	1152	193
35	1280	193
36	1536	257
37	1920	257
38	1280	129
39	1536	129
ЗA	1792	257
3B	2048	257
3C	2304	385
3D	2560	385
ЗE	3072	513
3F	3840	513





Figure 13-11. Typical IIC Interrupt Routine

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Chapter 14 Analog-to-Digital Converter (S08ADC10V1)



Figure 14-10. Configuration Register (ADC1CFG)

Table 14-5. ADC1CFG Register Field Descriptions

Field	Description
7 ADLPC	 Low Power Configuration — ADLPC controls the speed and power configuration of the successive approximation converter. This is used to optimize power consumption when higher sample rates are not required. 0 High speed configuration 1 Low power configuration: {FC31}The power is reduced at the expense of maximum clock speed.
6:5 ADIV	Clock Divide Select — ADIV select the divide ratio used by the ADC to generate the internal clock ADCK. Table 14-6 shows the available clock configurations.
4 ADLSMP	 Long Sample Time Configuration — ADLSMP selects between long and short sample time. This adjusts the sample period to allow higher impedance inputs to be accurately sampled or to maximize conversion speed for lower impedance inputs. Longer sample times can also be used to lower overall power consumption when continuous conversions are enabled if high conversion rates are not required. Short sample time Long sample time
3:2 MODE	Conversion Mode Selection — MODE bits are used to select between 10- or 8-bit operation. See Table 14-7.
1:0 ADICLK	Input Clock Select — ADICLK bits select the input clock source to generate the internal clock ADCK. See Table 14-8.

Table 14-6. Clock Divide Select

ADIV	Divide Ratio	Clock Rate
00	1	Input clock
01	2	Input clock ÷ 2
10	4	Input clock ÷ 4
11	8	Input clock ÷ 8

Table 14-7. Conversion Modes

MODE	Mode Description
00	8-bit conversion (N=8)
01	Reserved
10	10-bit conversion (N=10)
11	Reserved



Field	Description
1 ADPC9	 ADC Pin Control 9 — ADPC9 is used to control the pin associated with channel AD9. 0 AD9 pin I/O control enabled 1 AD9 pin I/O control disabled
0 ADPC8	 ADC Pin Control 8 — ADPC8 is used to control the pin associated with channel AD8. 0 AD8 pin I/O control enabled 1 AD8 pin I/O control disabled

Table 14-10. APCTL2 Register Field Descriptions (continued)

14.4.10 Pin Control 3 Register (APCTL3)

APCTL3 is used to control channels 16–23 of the ADC module.



Figure 14-13. Pin Control 3 Register (APCTL3)

Field	Description
7 ADPC23	 ADC Pin Control 23 — ADPC23 is used to control the pin associated with channel AD23. 0 AD23 pin I/O control enabled 1 AD23 pin I/O control disabled
6 ADPC22	 ADC Pin Control 22 — ADPC22 is used to control the pin associated with channel AD22. AD22 pin I/O control enabled AD22 pin I/O control disabled
5 ADPC21	 ADC Pin Control 21 — ADPC21 is used to control the pin associated with channel AD21. 0 AD21 pin I/O control enabled 1 AD21 pin I/O control disabled
4 ADPC20	 ADC Pin Control 20 — ADPC20 is used to control the pin associated with channel AD20. 0 AD20 pin I/O control enabled 1 AD20 pin I/O control disabled
3 ADPC19	 ADC Pin Control 19 — ADPC19 is used to control the pin associated with channel AD19. 0 AD19 pin I/O control enabled 1 AD19 pin I/O control disabled
2 ADPC18	 ADC Pin Control 18 — ADPC18 is used to control the pin associated with channel AD18. 0 AD18 pin I/O control enabled 1 AD18 pin I/O control disabled



Chapter 14 Analog-to-Digital Converter (S08ADC10V1)

converter yields the lower code (and vice-versa). However, even very small amounts of system noise can cause the converter to be indeterminate (between two codes) for a range of input voltages around the transition voltage. This range is normally around 1/2LSB and will increase with noise. This error may be reduced by repeatedly sampling the input and averaging the result. Additionally the techniques discussed in Section 14.7.2.3 will reduce this error.

Non-monotonicity is defined as when, except for code jitter, the converter converts to a lower code for a higher input voltage. Missing codes are those values which are never converted for any input value.

In 8-bit or 10-bit mode, the ADC is guaranteed to be monotonic and to have no missing codes.



A force-type breakpoint waits for the current instruction to finish and then acts upon the breakpoint request. The usual action in response to a breakpoint is to go to active background mode rather than continuing to the next instruction in the user application program.

The tag vs. force terminology is used in two contexts within the debug module. The first context refers to breakpoint requests from the debug module to the CPU. The second refers to match signals from the comparators to the debugger control logic. When a tag-type break request is sent to the CPU, a signal is entered into the instruction queue along with the opcode so that if/when this opcode ever executes, the CPU will effectively replace the tagged opcode with a BGND opcode so the CPU goes to active background mode rather than executing the tagged instruction. When the TRGSEL control bit in the DBGT register is set to select tag-type operation, the output from comparator A or B is qualified by a block of logic in the debug module that tracks opcodes and only produces a trigger to the debugger if the opcode at the compare address is actually executed. There is separate opcode tracking logic for each comparator so more than one compare event can be tracked through the instruction queue at a time.

15.3.5 Trigger Modes

The trigger mode controls the overall behavior of a debug run. The 4-bit TRG field in the DBGT register selects one of nine trigger modes. When TRGSEL = 1 in the DBGT register, the output of the comparator must propagate through an opcode tracking circuit before triggering FIFO actions. The BEGIN bit in DBGT chooses whether the FIFO begins storing data when the qualified trigger is detected (begin trace), or the FIFO stores data in a circular fashion from the time it is armed until the qualified trigger is detected (end trigger).

A debug run is started by writing a 1 to the ARM bit in the DBGC register, which sets the ARMF flag and clears the AF and BF flags and the CNT bits in DBGS. A begin-trace debug run ends when the FIFO gets full. An end-trace run ends when the selected trigger event occurs. Any debug run can be stopped manually by writing a 0 to ARM or DBGEN in DBGC.

In all trigger modes except event-only modes, the FIFO stores change-of-flow addresses. In event-only trigger modes, the FIFO stores data in the low-order eight bits of the FIFO.

The BEGIN control bit is ignored in event-only trigger modes and all such debug runs are begin type traces. When TRGSEL = 1 to select opcode fetch triggers, it is not necessary to use R/W in comparisons because opcode tags would only apply to opcode fetches that are always read cycles. It would also be unusual to specify TRGSEL = 1 while using a full mode trigger because the opcode value is normally known at a particular address.

The following trigger mode descriptions only state the primary comparator conditions that lead to a trigger. Either comparator can usually be further qualified with R/W by setting RWAEN (RWBEN) and the corresponding RWA (RWB) value to be matched against R/W. The signal from the comparator with optional R/W qualification is used to request a CPU breakpoint if BRKEN = 1 and TAG determines whether the CPU request will be a tag request or a force request.



 $^{8}\,$ IRQ does not have a clamp diode to V_{DD} Do not drive IRQ above V_{DD}



Figure A-1. Typical Low-Side Driver (Sink) Characteristics — Low Drive (PTxDS_n = 0)



Figure A-2. Typical Low-Side Driver (Sink) Characteristics — High Drive ($PTxDS_n = 1$)



Appendix A Electrical Characteristics and Timing Specifications



Internal Oscillator Deviation from Trimmed Frequency

Device trimmed at 25°C at 3.0 V.





NOTES:

- 1. DIMENSIONS ARE IN MILLIMETERS.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- 3. DATUMS A, B AND D TO BE DETERMINED AT DATUM PLANE H.

/4. DIMENSIONS TO BE DETERMINED AT SEATING PLANE C.

/5]. THIS DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED THE UPPER LIMIT BY MORE THAN 0.08 mm AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD SHALL NOT BE LESS THAN 0.07 mm.

/6. THIS DIMENSION DOES NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25 mm PER SIDE. THIS DIMENSION IS MAXIMUM PLASTIC BODY SIZE DIMENSION INCLUDING MOLD MISMATCH.



/8]

/7. EXACT SHAPE OF EACH CORNER IS OPTIONAL.

THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.1 mm AND 0.25 mm FROM THE LEAD TIP.

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TITLE: 64LD LQFP, 10 X 10 X 1.4 PKG, 0.5 PITCH, CASE OUTLINE		DOCUMENT NO	: 98ASS23234W	REV: E
		CASE NUMBER	2: 840F-02	11 AUG 2006
		STANDARD: JEDEC MS-026 BCD		